

Dual P-Channel 40-V (D-S) MOSFET

Description

The device is using trench DMOS technology. This advanced technology has been especially tailored to minimize R_{DS(ON)}, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Features

- $R_{DS(ON)} = 45m\Omega @ V_{GS} = 10V$
- Fast switching
- Improve dv/dt Capability
- 100% EAS Guaranteed
- Green Device Available

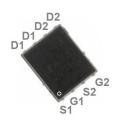
Typical Applications

- Motor Drive
- LED Lighting
- Hand-held Device

Package type: PDFN 5X6 Dual

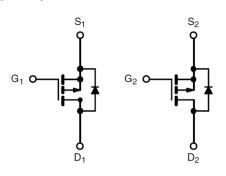
Packing & Order Information

3,000/Reel

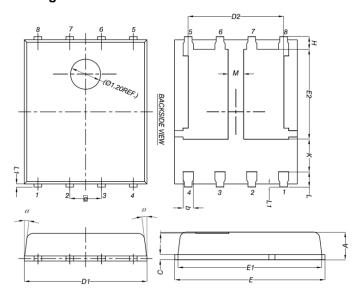


RoHS Compliant

Graphic Symbol

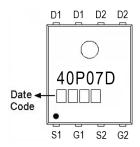


Package Dimension



REF.	Millimeter		REF.	Millimeter				
	Min.	Nom.	Max.	KEF.	Min.	Nom.	Max.	
Α	0.90	1.10	1.10	E2	3.38	3.58	3.78	
b	0.33	0.41	0.51	Ι	0.41	0.51	0.61	
С	0.20	0.25	0.30	K	1.10	-	6.20	
D1	4.80	4.90	5.00	L	0.51	0.61	0.71	
D2	3.61	3.81	3.96	L1	0.06	0.13	0.20	
Е	5.90	6.00	6.10	М	0.50	-	-	
E1	5.70	5.75	5.80	а	0℃	-	12°C	
е	1.27 BSC				•	•	•	

Marking





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)					
Symbol	Parameter	Value	Unit		
V _{DS}	Drain-Source Voltage	-40	V		
V _G s	Gate-Source Voltage	±20	V		
lo	Continuous Drain Current @ T _C =25°C	-18.8	Α		
	Continuous Drain Current @ T _C =70°C	-14	Α		
Ірм	Pulsed Drain Current ²	-50	Α		
I _{AS}	Single Pulse Avalanche Current, L =0.1mH ³	-24	Α		
Eas	Single Pulse Avalanche Energy, L =0.1mH ³	28.8	mJ		
P _D	Power Dissipation (Tc=25°C)	25	W		
T _j , T _{stg}	Operating Junction and Storage Temperature	-55~+150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Value	Unit		
R _{θJA}	Maximum Junction-to-Ambient ¹	85	°C/W		
R _{θJC}	Maximum Junction-to-Case	5	°C/W		

Electrical Characteristics (T _J =25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V _{GS (th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250μA	-1	-	-2.5	V
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-40	-	-	V
I _{GSS}	Gate-Source Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
I	Drain-Source Leakage Current	V _{DS} =-32V, V _{GS} =0V, T _J =25°C			-1	μΑ
I _{DSS}		V _{DS} =-32V, V _{GS} =0V, T _J =55°C			-5	
D	Static Drain-Source On-Resistance ²	V _{GS} =-10V, I _D =-6A	-	38	45	m0
R _{DS} (on)		V _{GS} =-4.5V, I _D =-4A	-	61	75	mΩ
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V, L =0.1mH, I _{AS} =-12A	7.2	-	-	mJ
V _{SD}	Diode Forward Voltage ²	Is=1A, V _{GS} =0V, T _J =25°C	-	-	-1.2	V
Is	Continuous Source Current ^{1,6}	V _G =V _D =0V, Force Current	-	-	-7	Δ.
Ism	Pulsed Source Current ^{2,6}		-	-	-14	А



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Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =-20V		9		
Q _{gs}	Gate-Source Charge	I _D =-6A		2.5		nC
Q_{gd}	Gate-Drain Charge	V _{GS} =-4.5V		3.1		
t _{d(on)}	Turn-On Delay Time ²	V _{DS} =-15V		19.2		
t _r	Rise Time	I _D =-1A		12.8		
t _{d(off)}	Turn-Off Delay Time	V _{GS} =-10V		48.6		ns
tf	Fall Time	R _G =3.3Ω		4.6		
Ciss	Input Capacitance	V _{DS} =-15V		1004		
Coss	Output Capacitance	V _{GS} =0V		108		pF
Crss	Reverse Transfer Capacitance	f =1.0MHz		80		
Rg	Gate Resistance	V _{DS} =0V, V _{GS} =0V, f =1.0MHz		16		Ω

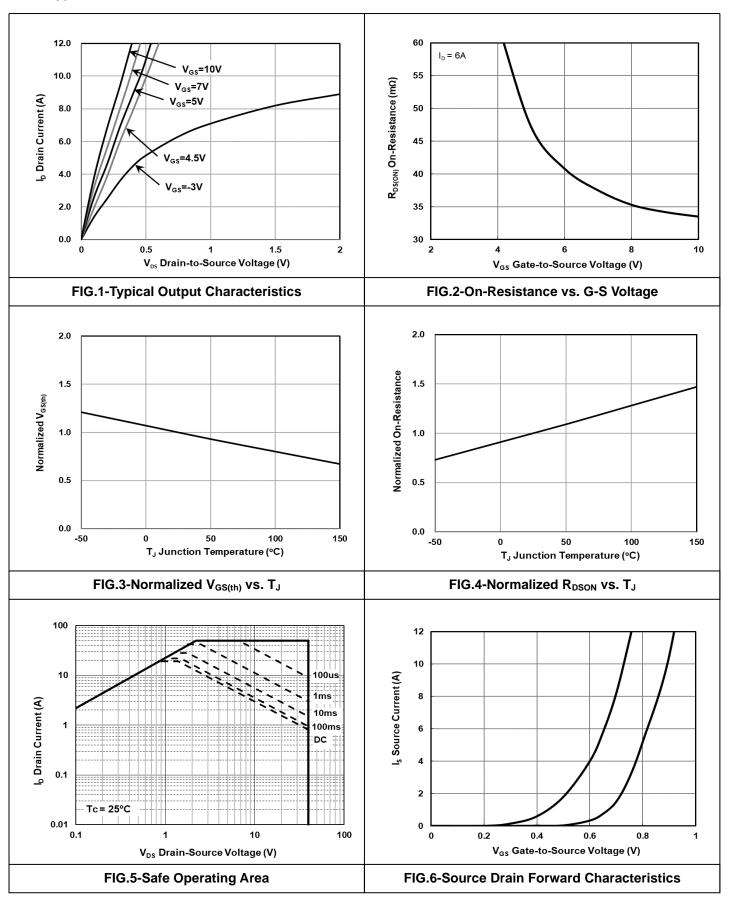
Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =-24A.
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



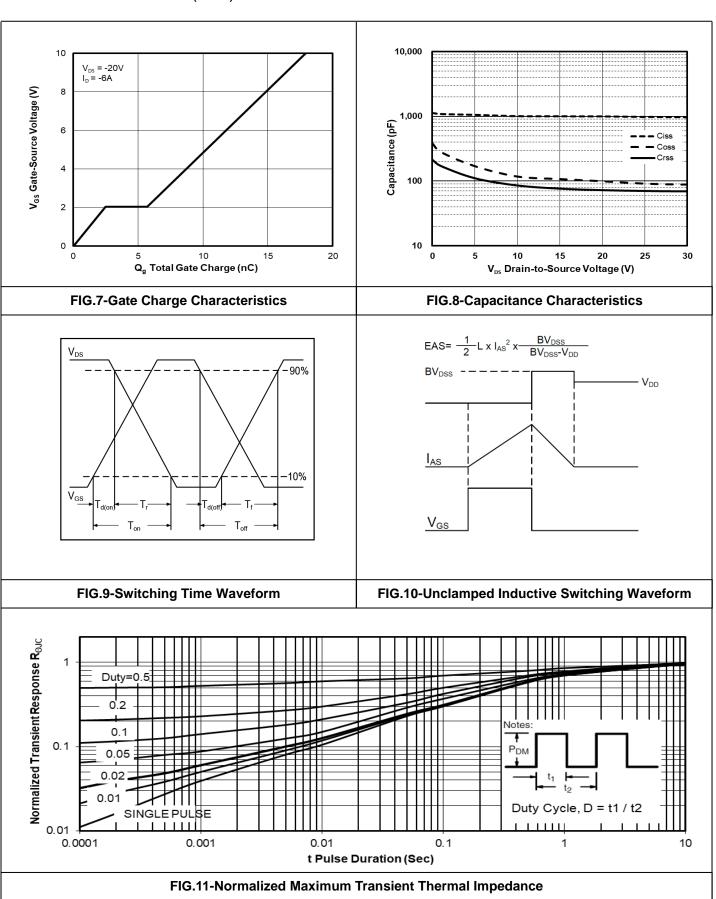
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Typical Electrical Characteristics





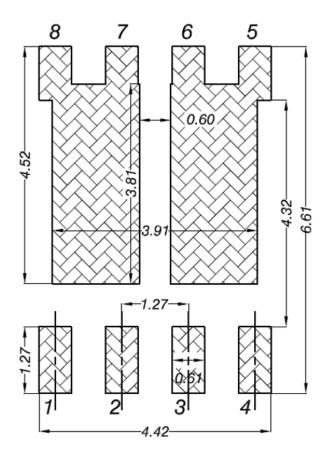
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Dual P-Channel 40-V (D-S) MOSFET

• Land Pattern (For Reference Only)





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